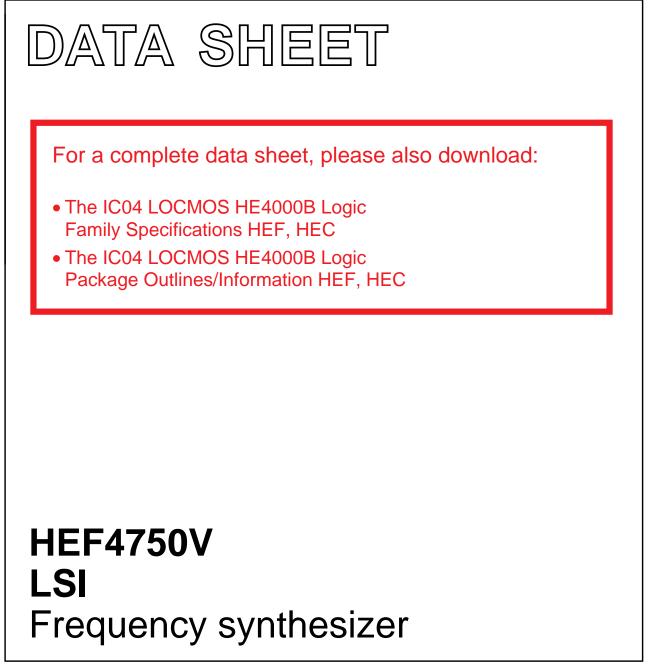
INTEGRATED CIRCUITS



Product specification File under Integrated Circuits, IC04 January 1995



HEF4750V LSI

DESCRIPTION

The HEF4750V frequency synthesizer is one of a pair of LOCMOS devices, primarily intended for use in high-performance frequency synthesizers, e.g. in all communication, instrumentation, television and broadcast applications. A combination of analogue and digital techniques results in an integrated circuit that enables high performance. The complementary device is the universal divider type HEF4751V.

Together with a standard prescaler, the two LOCMOS integrated circuits offer low-cost single loop synthesizers with full professional performance. Salient features offered (in combination with HEF4751V) are:

- Wide choice of reference frequency using a single crystal.
- High-performance phase comparator low phase noise low spurii.
- System operation to > 1 GHz.
- Typical 15 MHz input at 10 V.
- Flexible programming:
 - frequency offsets
 - **ROM** compatible
 - fractional channel capability.
- Programme range 6¹/₂ decades, including up to 3 decades of prescaler control.
- Division range extension by cascading.
- Built-in phase modulator.
- Fast lock feature.
- Out-of-lock indication.
- Low power dissipation and high noise immunity.

APPLICATION INFORMATION

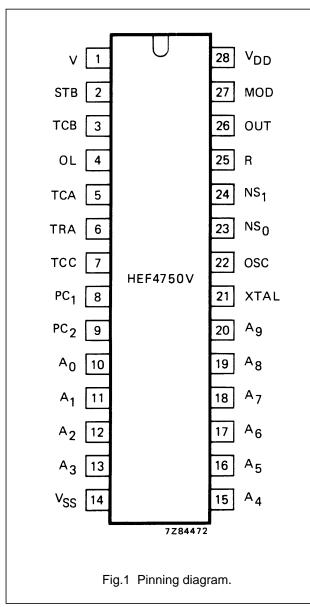
Some examples of applications for the HEF4750V in combination with the HEF4751V are:

- VHF/UHF mobile radios.
- HF s.s.b. transceivers.
- Airborne and marine communications and navaids.
- Broadcast transmitters.
- High quality radio and television receivers.
- High performance citizens band equipment.
- Signal generators.

SUPPLY VOLTAGE

RATING	RECOMMENDED OPERATING
-0,5 to +15	9,5 to 10,5 V

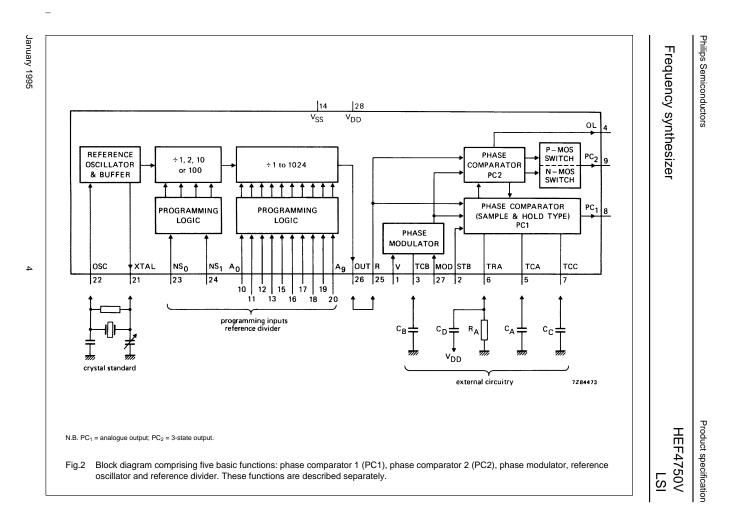
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HEF4750VD(F): 28-lead DIL; ceramic (cerdip) (SOT135)

(): Package Designator North America

PINNING	
R	phase comparator input, reference
V	phase comparator input
STB	strobe input
TCA	timing capacitor C _A pin
тсв	timing capacitor C _B pin
TCC	timing capacitor C _C pin
TRA	biasing pin (resistor R _A)
PC ₁	analogue phase comparator output
PC ₂	digital phase comparator output
MOD	phase modulation input
OL	out-of-lock indication
OSC	reference oscillator/buffer input
XTAL	reference oscillator/buffer output
A_0 to A_9	programming inputs/programmable divider
NS ₀ , NS ₁	programming inputs, prescaler
OUT	reference divider output



HEF4750V LSI

Frequency synthesizer

FUNCTIONAL DESCRIPTION

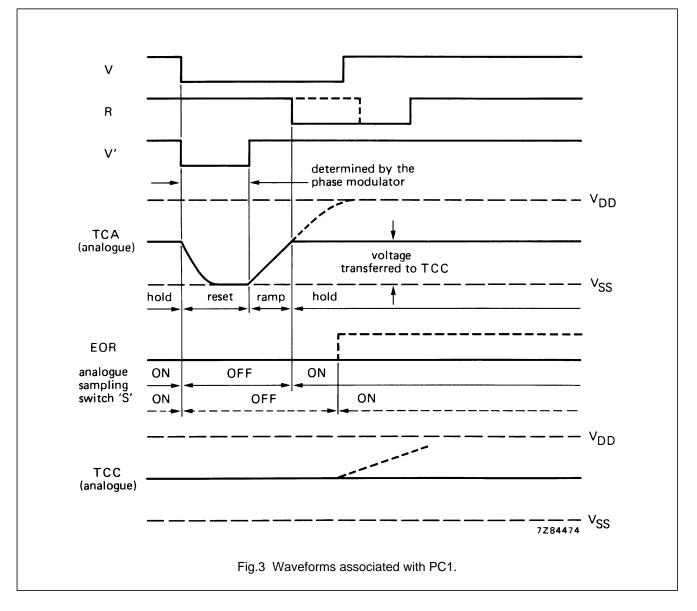
Phase comparator 1

Phase comparator 1 (PC1) is built around a SAMPLE and HOLD circuit. A negative-going transition at the V-input causes the hold capacitor (C_A) to be discharged and after a specified delay, caused by the Phase Modulator by means of an internal V' pulse, it produces a positive-going ramp. A negative-going transition at the R-input terminates

the ramp. Capacitor C_A holds the voltage that the ramp has attained. Via an internal sampling switch this voltage is transferred to C_C and in turn buffered and made available at output PC₁.

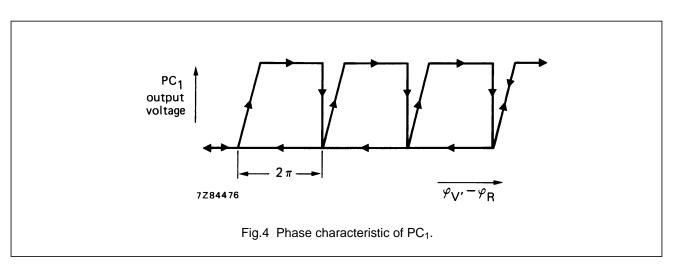
If the ramp terminates before an R-input is present, an internal end of ramp (EOR) signal is produced.

These actions are illustrated in Fig.3.



The resultant phase characteristic is shown in Fig.4.

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PC1 is designed to have a high gain, typically 3200 V/cycle (at 12,5 kHz). This enables a low noise performance.

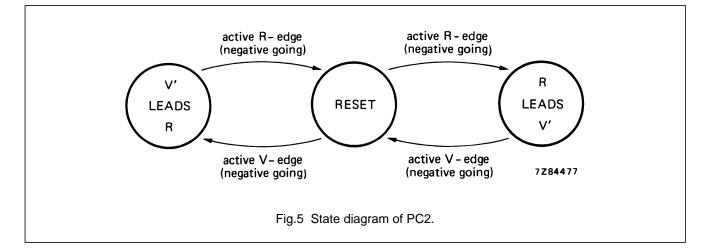
Phase comparator 2

Phase comparator 2 (PC2) has a wide range, which enables faster lock times to be achieved than otherwise would be possible. It has a linear \pm 360° phase range, which corresponds to a gain of typically 5 V/cycle.

This digital phase comparator has three stable states:

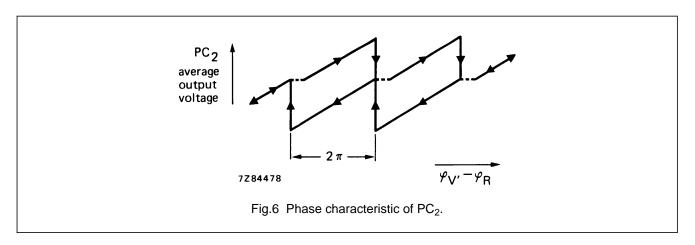
- reset state,
- V' leads R state,
- R leads V' state.

Conversion from one state to another takes place according to the state diagram of Fig.5.



Output PC₂ produces positive or negative-going pulses with variable width; they depend on the phase relationship of R and V'. The average output voltage is a linear function of the phase difference. Output PC₂ remains in the high impedance OFF-state in the region in which PC1 operates. The resultant phase characteristic is shown in Fig.6.

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Strobe function

The strobe function is intended for applications requiring extremely fast lock times. In normal operation the additional strobe input (STB) can be connected to the V-input and the circuit will function as described in the previous sections.

In single, phase-locked-loop type frequency synthesizers, the comparison frequency generally used is either the nominal channel spacing or a sub-multiple. PC2 runs at the higher frequency (a higher reference frequency must also be used), whilst strobing takes place on the lower frequency, thereby obtaining a decrease in lock time. In a system using the Universal Divider HEF4751V, the output OFS cycles on the lower frequency, the output OFF cycles on the higher frequency.

Out-of-lock function

There are a number of situations in which the system goes from the locked to the out-of-lock state (OL goes HIGH):

- 1. When V' leads R, however out of the range of PC1.
- 2. When R leads V'.
- 3. When an R-pulse is missing.
- 4. When a V-pulse is missing.
- 5. When two successive STB-commands occur, the first without corresponding V-signal.

Phase modulator

The phase modulator only uses one external capacitor, C_B at pin TCB. A negative-going transition at the V-input causes C_B to produce a positive-going linear ramp. When the ramp has reached a value almost equal to the modulation input voltage (at MOD), the ramp terminates, C_B discharges and a start signal to the C_A -ramp at TCA is produced. A linear phase modulation is reached in this

way. If no modulation is required, the MOD-input must be connected to a fixed voltage of a certain positive value up to V_{DD} . Care must be taken that the V' pulse is never smaller than the minimum value to ensure that the external capacitor of PC1 (C_A) can be discharged during that time. Since the V' pulse width is directly related to the TCB ramp duration, there is a requirement for the minimum value of this ramp duration.

Reference oscillator

The reference oscillator normally operates with an external crystal as shown in Fig.2. The internal circuitry can be used as a buffer amplifier in case an external reference should be required.

Reference divider

The reference divider consists of a binary divider with a programmable division ratio of 1 to 1024 and a prescaler with selectable division ratios of 1, 2, 10 and 100, according to the following tables:

Binary divider

N (A ₀ TO A ₉)	DIVISION RATIO
0	1024
$0 \le N \le 1023$	Ν

Prescaler

PROGRAMMING WORD (NS ₀ , NS ₁)	DIVISION RATIO
0	1
1	2
2	10
3	100

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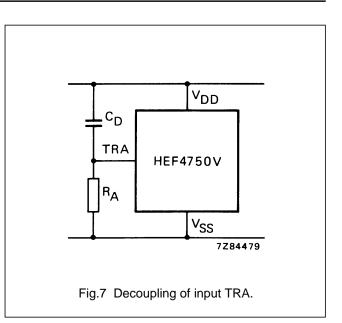
LSI

Frequency synthesizer

In this way suitable comparison frequencies can be obtained from a range of crystal frequencies. The divider can also be used as a 'stand alone' programmable divider by connecting input TRA to V_{DD} , which causes all internal analogue currents to be switched off.

Biasing circuitry

The biasing circuitry uses an external current source or resistor, which has to be connected between the TRA and V_{SS} pins. This circuitry supplies all analogue parts of the circuit. Consequently the analogue properties of the device, such as gain, charge currents, speed, power dissipation, impedance levels etc., are mainly determined by the value of the input current at TRA. The TRA input must be decoupled to V_{DD} , as shown in Fig.7. The value of C_D has to be chosen such that the TRA input is 'clean', e.g. 10 nF at $R_A = 68 \text{ k}\Omega$.



RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Supply voltage	V _{DD}	-0,5	to + 15 V
Voltage on any input	VI	–0,5 to V_{D}	_{DD} + 0,5 V
D.C. current into any input or output	±Ι	max.	10 mA
Power dissipation per package			
for $T_{amb} = 0$ to + 85 °C	P _{tot}	max.	500 mW
Power dissipation per output			
for $T_{amb} = 0$ to 85 °C	Р	max.	100 mW
Storage temperature	T _{stg}	–65 te	o + 150 °C
Operating ambient temperature	T_{amb}	-40 te	o +85 °C

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DC CHARACTERISTICS

at V_{DD} = 10 V ± 5%; voltages are referenced to V_{SS} = 0 V, unless otherwise specified; for definitions see note 1.

		T _{amb} (°C										
PARAMETER	SYMBOL	-40			+ 25			+ 85				NOTES
		MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.		
Quiescent device												
current	I _{DD}	_	_	100	_	_	100	_	_	750	μA	2
Input current; logic												
inputs, MOD	± I _{IN}	_	_	300	_	_	300	_	_	1000	nA	3
Output leakage current												
at $\frac{1}{2}$ V _{DD}												3,4
TCA, hold-state	$\pm I_Z$	_	_	20	_	0,05	20	_	_	60	nA	
TCC, analogue												
switch OFF	$\pm I_Z$	_	_	20	_	0,05	20	_	_	60	nA	
PC ₂ , high impedance						-,						
OFF-state	$\pm I_Z$	_	_	50	_	_	50	_	_	500	nA	
Logic input voltage												
LOW	VIL				 ma	ax. 0,3	Vpp				v	
HIGH						ax. 0,7					v	
Logic output voltage	VIH					IX. 0,7	• DD				V	
LOW; at $ I_0 < 1 \mu A$	V _{OL}		_	50		_	50		_	50	mV	3
HIGH	Vol Voн			50	1	V	50 mV -	I		50	mV	3
Logic output current	⊻ОН				- 11111. 	v DD — .	50 m -					5
LOW; at $V_{OL} = 0.5 V$												3
												3
outputs OL, PC ₂ , OUT		FF			10			2.0				
	I _{OL}	5,5	_	-	4,6	_	-	3,6	_	_	mA	
output XTAL	I _{OL}	2,8	_	_	2,4	-	_	1,9	_	_	mA	
Logic output current												
HIGH;												
at $V_{OH} = V_{DD} - 0.5 V$.	4.5										3
outputs OL, PC ₂ ,OUT	–I _{OH}	1,5	-	-	1,3	_	-	1,0	-	-	mA	
output XTAL	–I _{OH}	1,4	_	_	1,2	_	_	0,9	_	_	mA	
Output TCC sink						. .						
current	lo	-	-	-	-	2,1	-	-	-	-	mA	3,4,5
Output TCC source												
current	-lo	-	-	-	-	1,9	-	-	-	-	mA	3,4,6
Internal resistance												
of TCC												
output swing ≤ 200 mV												
specified output range:												
0,3 V _{DD} to 0,7 V _{DD}	R _i	-	_	_	_	0,7	_	_	_	_	kΩ	3,4

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					7	ר _{amb} (°	С					
PARAMETER	SYMBOL	-40			+ 25			+ 85				NOTES
		MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.		
Output TCC voltage												
with respect to												
TCA input voltage	ΔV	-	0	_	-	0	_	-	0	_	V	3,4,7
Output PC ₁ sink												
current	lo	-	_	_	-	1,1	_	-	_	_	mA	3,4,8
Output PC ₁ source												
current	-lo	-	_	_	-	1,0	_	-	_	_	mA	3,4,9
Internal resistance												
of PC ₁												
output swing												
≤ 200 mV												
specified output range:												
0,3 V _{DD} to 0,7 V _{DD}	R _i	-	-	-	-	1,4	-	-	-	_	kΩ	3,4
Output PC ₁ voltage												
with respect to												
TCC input voltage	ΔV	-	0	-	-	0	-	-	0	-	V	3,4,10
EOR generation												
$V_{EOR} = V_{DD} - V_{TCA}$	V _{EOR}	-	0,9	_	-	0,7	_	-	0,6	_	V	3,4,11
Source current; HIGH												
at V _{OUT} = ½ V _{DD} ;												
output in ramp mode												3,4
TCA	Io	-	_	_	_	13	_	-	_	_	mA	
тсв	lo	_	_	_	_	2,5	_	_	_	_	mA	

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AC CHARACTERISTICS

General note

The dynamic specifications are given for the circuit built-up with external components as given in Fig.8, under the following conditions; for definitions see note 1; for definitions of times see Fig.19; $V_{DD} = 10 \text{ V} \pm 5\%$; $T_{amb} = 25 \text{ °C}$; input transition times $\leq 20 \text{ ns}$; $R_A = 68 \text{ k}\Omega \pm 30\%$ (see also note 4); $C_A = 270 \text{ pF}$; $C_B = 150 \text{ pF}$; $C_C = 1 \text{ nF}$; $C_D = 10 \text{ nF}$; unless otherwise specified.

	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS	NOTES
Slew rate							
ТСА	S _{TCA}	_	52	_	V/µs	R _A = minimum	12
ТСА	S _{TCA}	_	28	_	V/µs	R _A = maximum	12
ТСВ	S _{TCB}	_	20	_	V/µs	R _A = minimum	12
ТСВ	S _{TCB}	_	10	_	V/µs	R _A = maximum	12
Ramp linearity							
ТСА	I _{TCA}	_	2	_	%		13
ТСВ	I _{TCB}	_	2	_	%		13
Start of TCA-ramp delay	t _{CBCA}	-	200	_	ns		
Delay of TCA-hold	t _{RCA}	_	40	_	ns		
Delay of TCA-discharge	t _{VCA}	_	60	_	ns		
Start of TCB-ramp delay	t _{VCB}	_	60	_	ns		
TCB-ramp duration	t _{rCB}	-	250	_	ns	$V_{MOD} = 4 V$	
	t _{rCB}	_	350	_	ns	$V_{MOD} = 6 V$	
	t _{rCB}	_	450	_	ns	V _{MOD} = 8 V	
Required TCB min.							
ramp duration	t _{rCB}	_	150	_	ns		14
Pulse width							
V : LOW	t _{PWVL}	_	20	_	ns		
V : HIGH	t _{PWVH}	_	20	_	ns		
R : LOW	t _{PWRL}	_	20	_	ns		
R : HIGH	t _{PWRH}	_	20	_	ns		
STB : LOW	t _{PWSL}	_	20	_	ns		
STB : HIGH	t _{PWSH}	_	20	_	ns		
Fall time							
ТСА	t _{fCA}	_	50	_	ns		
ТСВ	t _{fCB}	_	50	_	ns		
Prescaler input frequency	f _{PR}	-	30	_	MHz	all division ratios	
Binary divider frequency	f _{DIV}	_	30	_	MHz	all division ratios	
Crystal oscillator frequency	f _{OSC}	_	10	_	MHz		
Average power supply current						locked state	
with speed-up 1 : 10	I _P	_	3,6	_	mA		15
without speed-up	I _P	_	3,2	_	mA		16

HEF4750V LSI

Notes

- 1. Definitions:
 - R_{A} = external biasing resistor between pins TRA and V_{SS}; 68 k\Omega \pm 30%.
 - C_A = external timing capacitor for time/voltage converter, between pins TCA and V_{SS} .
 - C_B = external timing capacitor for phase modulator, between pins TCB and V_{SS}.
 - C_C = external hold capacitor between pins TCC and V_{SS}.
 - C_D = decoupling capacitor between pins TRA and V_{DD} .
 - Logic inputs: V, R, STB, A₀ to A₉, NS₀, NS₁, OSC.
 - Logic outputs: OL, PC₂, XTAL, OUT.
 - Analogue signals: TCA, TCB, TCC, TRA, PC₁, MOD.
- 2. TRA at V_{DD} ; TCA, TCB, TCC and MOD at V_{SS} ; logic inputs at V_{SS} or V_{DD} .
- 3. All logic inputs at V_{SS} or V_{DD} .
- 4. R_A connected; its value chosen such that $I_{TRA} = 100 \ \mu A$.
- 5. The analogue switch is in the ON position (see Fig.9).
- 6. The analogue switch is in the ON position (see Fig.10).

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7. See Fig.11.
```

This guarantees the d.c. voltage gain, combined with d.c.-offset. Input condition: 0,3 V_{DD} \leq V_{TCA} \leq 0,7 $V_{DD}.$

$$\Delta \mathsf{V} = \mathsf{V}_{\mathsf{TCC}} - \mathsf{V}_{\mathsf{TCA}}$$

- 8. See Fig.12.
- 9. See Fig.13.
- 10. See Fig.14.

This guarantees the d.c. voltage gain, combined with d.c.-offset. Input condition: 0,3 $V_{DD} \leq V_{TCC} \leq 0,7 \ V_{DD}$. $\Delta V = V_{PC1} - V_{TCC}$.

- 11. Switching level at TCA, generating an EOR-signal, during increasing input voltage.
- 12. See Fig.15.

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13. See Fig.16.
```

Definition of the ramp linearity at full swing.

- 14. The external components and modulation input voltage must be chosen such that this requirement will be fulfilled, to ensure that C_A is sufficiently discharged during that time.
- 15. See Fig.17.

Circuit connections for power supply current specification, with speed-up 1 : 10. V and R are in the range of PC1, such that the output voltage at PC_1 is equal to 5 V.

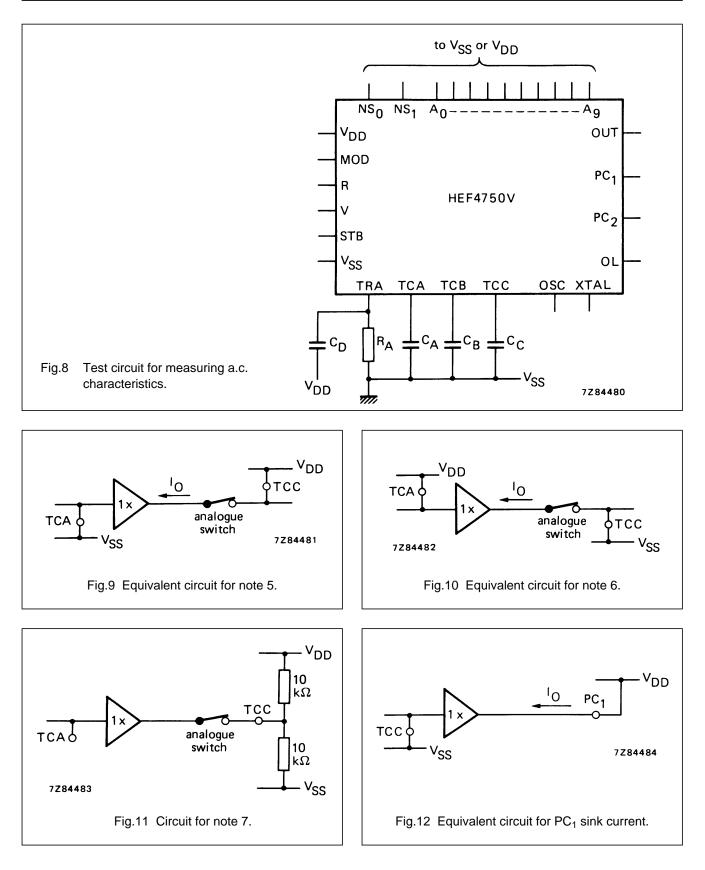
 $f_{OSC} = 5 \text{ MHz}$ (external clock) $f_{STB} = 12,5 \text{ kHz}$ $f_V = 125 \text{ kHz}$

16. See Fig.18.

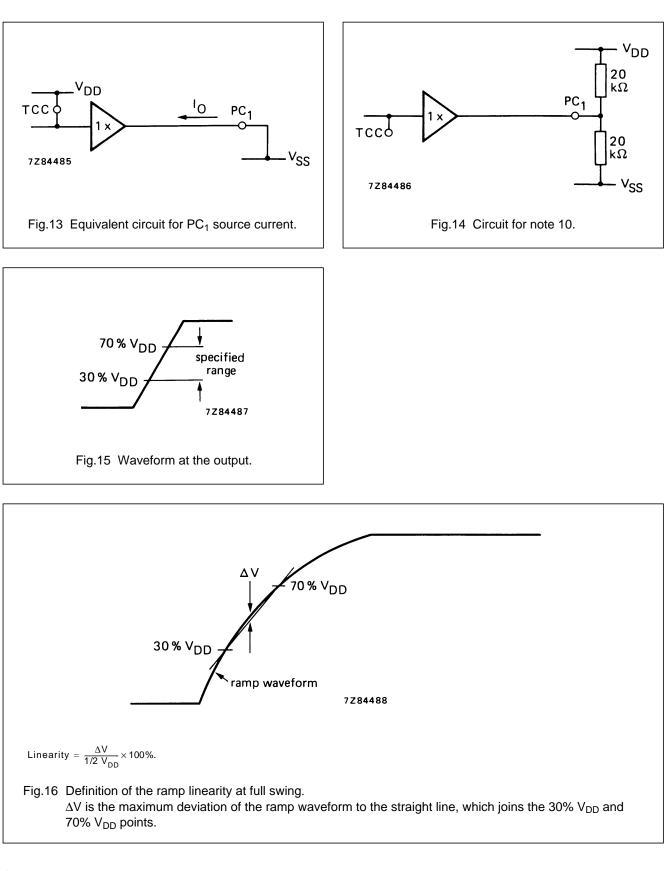
Circuit connections for power supply current specification, without speed-up. V and R are in the range of PC1, such that the output voltage at PC_1 is equal to 5 V.

 $f_{OSC} = 5$ MHz (external clock) $f_{STB} = 12,5$ kHz $f_V = 12,5$ kHz



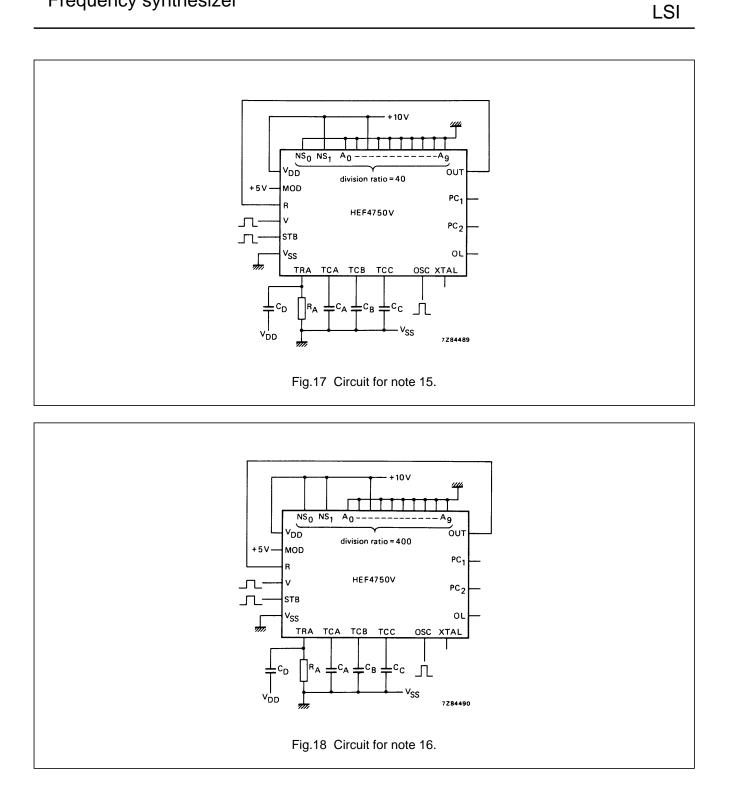


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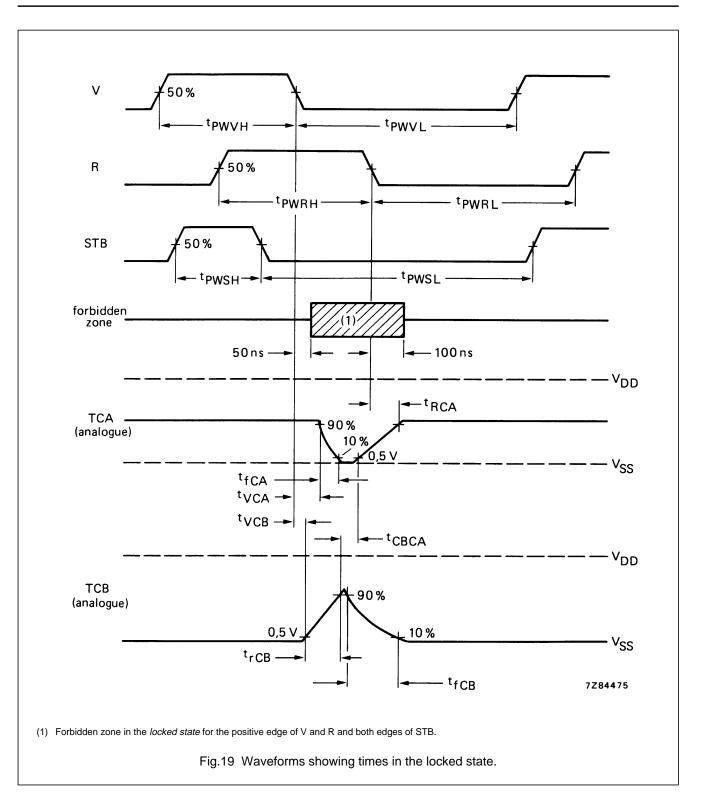


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APPLICATION INFORMATION

